

## **RF Test Report**

## For

### **Applicant Name:**

Address:

EUT Name: Brand Name: Model Number: Series Model Number:

### **TECNO MOBILE LIMITED**

FLAT N 16/F BLOCK B UNIVERSAL INDUSTRIAL CENTRE 19-25 SHAN MEI STREET FOTAN NT HONGKONG Laptop Computer TECNO T14DA Refer to Section 2

## **Issued By**

### **Company Name:**

**BTF Testing Lab (Shenzhen) Co., Ltd.** F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Address:

Report Number: Test Standards: FCC ID: Test Conclusion: Test Date: Date of Issue:

Prepared By:

Date:

Approved By:

Date:

BTF230918R00105 47 CFR Part 15 Subpart E Section 15.407 2ADYY-T14DA Pass 2023-08-29 to 2023-09-19 2023-09-20

(Shenzh Chris Liu / Project E o eer 2023-09-2 SZ

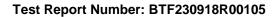
Ryan.CJ / EMC Manager 2023-09-20

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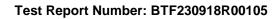
Revision History					
Version	Issue Date	Issue Date Revisions Content			
R_V0	2023-09-20	Original			
	and the second se	and the second s			
Note:	Once the revision has	Once the revision has been made, then previous versions reports are invalid.			





### **Table of Contents**

1.	Introc	luction	4
	1.1	Identification of Testing Laboratory	4
	1.2	Identification of the Responsible Testing Location	4
	1.3	Laboratory Condition	4
	1.4	Announcement	4
2.	Produ	Ict Information	5
	2.1	Application Information	5
	2.2	Manufacturer Information	5
	2.3	Factory Information	5
	2.4	General Description of Equipment under Test (EUT)	5
	2.5	Technical Information	6
3.	Sumr	nary of Test Results	7
	3.1	Test Standards	7
	3.2	Summary of Test Result	7
	3.3	Uncertainty of Test	7
4.	Test (	Configuration	8
	4.1	Environment Condition	8
	4.2	Test Equipment List	8
	4.3	Test Auxiliary Equipment	8
	4.4	Test Setup	9
5.	DFS	TEST INFORMATION	.10
	5.1	DFS test requirement	.10
	5.2	DFS Detection Thresholds	.13
	5.3	Radar Test Waveforms	.14
6.	Test I	tem	.17
	6.1	Calibration of Radar Waveform	.17
	6.2	Channel Move Time, Channel Closing Transmission Time	.18
AN	NEX A	Test Results	.20





## 1. Introduction

## 1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address: F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, T Community, Songgang Street, Bao'an District, Shenzhen, China	
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

### **1.2 Identification of the Responsible Testing Location**

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number:	518915
Designation Number:	CN1330

### **1.3 Laboratory Condition**

· · · · –	
Ambient Temperature:	20°C to 25°C
Ambient Relative Humidity:	45% to 55%
Ambient Pressure:	100 kPa to 102 kPa

### **1.4 Announcement**

- (1) The test report reference to the report template version v0.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.
- (5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



## 2. Product Information

### 2.1 Application Information

Company Name:	TECNO MOBILE LIMITED
Address:	FLAT N 16/F BLOCK B UNIVERSAL INDUSTRIAL CENTRE 19-25 SHAN MEI STREET FOTAN NT HONGKONG

### 2.2 Manufacturer Information

Company Name:	TECNO MOBILE LIMITED
Address:	FLAT N 16/F BLOCK B UNIVERSAL INDUSTRIAL CENTRE 19-25 SHAN MEI STREET FOTAN NT HONGKONG

## 2.3 Factory Information

Company Name:	GUANGXI SHANCHAUN TECHNOLOGY CO LTD		
Address:	The Second Floor of Plant C01, Plant C02, Plant C03 and Plant D03 Guangxi Sannuo Smart Industrial Park, No.3, Gaoke Road, Beihai Industrial Park, BEIHAI, 536000 Guangxi, P.R.China		

## 2.4 General Description of Equipment under Test (EUT)

EUT Name	Laptop Computer
Test Model Name	T14DA
Series Model Name	N/A
Software Version:	Win 11 home
Hardware Version:	N156EBC01_MB_V11 VB



Page 6 of 22

## 2.5 Technical Information

Modulation technology	OFDM/OFDMA					
Modulation Type	BPSK, QPSK, 16QAM, 64QAM, 256QAM,1024QAM					
Function	□ Outdoor AP □ Indoor AP □ Fixed P2P ⊠ Client					
DFS type	□ Master □ Slave with radar detection ⊠ Slave without radar detection					
Operation Frequency Range	U-NII Band 2A: 5.25~5.32 GHz U-NII Band 2C: 5.50~5.70GHz					
Frequency Block	U-NII Band 2A: 5.25~5.35 GHz U-NII Band 2C: 5.470~5.725 GHz					
Channel Bandwidth	802.11a: 20 MHz 802.11n: 20 MHz, 40 MHz 802.11ac: 20 MHz, 40 MHz, 80MHz 802.11ax: 20 MHz, 40 MHz, 80MHz, 160MHz					
Antenna Type	Integral Antenna					
Antenna Gain <sup>#</sup> 5250-5350 5.4dBi 5470-5725 5.4dBi						
Antenna Impedance	50Ω					

Note:

#: The antenna gain provided by the applicant, and the laboratory will not be responsible for the accumulated calculation results which covers the information provided by the applicant.

According to section 15.31(m), regards to the operating frequency range over 10 MHz, must select three channels which were tested. The Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, please see the below .

Band	Test Channel	20MHz		40MHz		80MHz		160MHz	
		Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
	CH∟	52	5260	54	5270	-	-	-	-
U-NII- 2A	CH <sub>M</sub>	56	5280	-	-	58	5290	50	5250
2/1	CH <sub>H</sub>	64	5320	62	5310	-	-	-	-
	CH∟	100	5500	102	5510	106	5530	-	-
U-NII-	CH <sub>M</sub>	116	5580	110	5550	122	5610	114	5570
2C	CH <sub>H</sub>	140	5700	134	5670	138	5690		
	CH <sub>H1</sub>	144	5720	142	5710				

## 3. Summary of Test Results

### 3.1 Test Standards

No.	Identity	Document Title		
1	47 CFR Part 15 Subpart E Section 15.407	Unlicensed National Information Infrastructure Devices		
2	ANSI C63.10-2013	American National Standard for Testing Unlicensed Wireless Devices		
3	KDB905462 D02 v02	COMPLIANCE MEASUREMENT PROCEDURES FOR UNLICENSED-NATIONAL INFORMATION INFRASTRUCTURE DEVICES OPERATING IN THE 5250-5350 MHz AND 5470-5725 MHz BANDS INCORPORATING DYNAMIC FREQUENCY SELECTION		
4	KDB905462 D03 v01r02	U-NII CLIENT DEVICES WITHOUT RADAR DETECTION CAPABILITY		
5	KDB905462 D04 v01	OPERATIONAL MODES SUGGESTED FOR DFS TESTING		

### 3.2 Summary of Test Result

No.	Description	FCC Part No.	Test Result	Test By	Verdict	Remark
1	Calibration of Radar Waveform	15.407(i)	ANNEX A	Gavin Cui	Pass	
2	Channel Move Time, Channel Closing Transmission Time	15.407(i)	ANNEX A	Gavin Cui	Pass	

## 3.3 Uncertainty of Test

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2 and TR100 028-1/-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Occupied Channel Bandwidth	69 KHz
RF output power, conducted	0.87 dB
Power Spectral Density, conducted	0.69 dB
Unwanted Emissions, conducted	0.94 dB
All emissions, radiated(<1GHz)	4.12 dB
All emissions, radiated(>1GHz)	4.16 dB
Temperature	0.82 °C
Humidity	4.1 %



## 4. Test Configuration

## 4.1 Environment Condition

	Environment		Selected Value	es During Tests			
	Parameter	Temperature	Voltage	Relative Humidity	Ambient Pressure		
·	Normal Temperature, Normal Voltage (NTNV)	20°C to 25°C	DC 12V from Adapter	30% to 60%	100 kPa to 102 kPa		

## 4.2 Test Equipment List

	Conducted Method Test					
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022.11.24	2023.11.23	$\boxtimes$
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022.11.24	2023.11.23	
ESG VECTOR SIGNAL GENERATOR	Agilent	E4438C	MY45094854	2022.11.24	2023.11.23	$\boxtimes$
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2022.11.24	2023.11.23	$\boxtimes$
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022.11.25	2023.11.24	$\boxtimes$
RF Control Unit	TST	TST-Full	S01	/	/	$\boxtimes$
RF Test software	TST	V2.0	/	/	/	$\boxtimes$

## 4.3 Test Auxiliary Equipment

Description	Manufacturer	Model	FCC ID	Use
Wireless AX5400	ASUS	RT-AX82U	/	$\boxtimes$
MXG Vector Signal Generator	KEYSIGHT	N5182B	/	$\boxtimes$
EXA Signal Analyzer	KEYSIGHT	N9010B	/	$\boxtimes$
Notebook	Lenovo	E490	/	$\boxtimes$

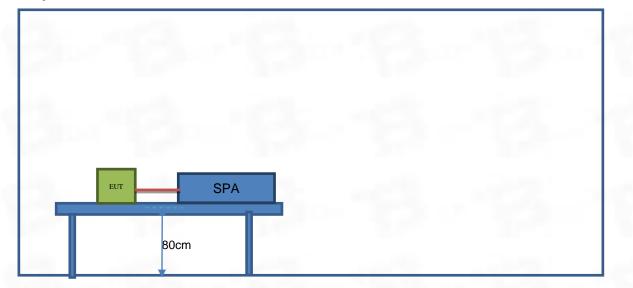
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Test Report Number: BTF230918R00105

## 4.4 Test Setup

Test Setup 1





## 5. DFS TEST INFORMATION

## 5.1 DFS test requirement

The following table from FCC KDB905462 D02 UNII DFS Compliance procedures new rules list the applicable requirements for the DFS testing.

	Operational Mode				
Requirement	Master	Client Without	Client With Radar		
		Radar Detection Detection			
Non-Occupancy Period	Yes	Not required	Yes		
DFS Detection Threshold	Yes	Not required	Yes		
Channel Availability Check Time	Yes	Not required	Not required		
U-NII Detection Bandwidth	Yes	Not required	Yes		

### Table 1: Applicability of DFS Requirements Prior to Use of a Channel

#### Table 2: Applicability of DFS requirements during normal operation

	Operational Mode		
Requirement	Master Device or Client with Radar Detection	Client Without Radar Detection	
DFS Detection Threshold	Yes	Not required	
Channel Closing Transmission Time	Yes	Yes	
Channel Move Time	Yes	Yes	
U-NII Detection Bandwidth	Yes	Not required	

Master Device or Client with Radar Detection	Client Without Radar Detection
All BW modes must be tested	Not required
Test using widest BW mode available	Test using the widest BW mode available for the link
Any single BW mode	Not required
	Radar Detection      All BW modes must be tested      Test using widest BW mode available

Note: Frequencies selected for statistical performance check (Section 7.8.4) should include several frequencies within the radar detection bandwidth and frequencies near the edge of the radar detection bandwidth. For 802.11 devices it is suggested to select frequencies in each of the bonded 20 MHz channels and the channel center frequency.

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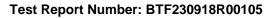


### Master Devices

- The Master Device will use DFS in order to detect Radar Waveforms with received signal strength above the DFS Detection Threshold in the 5250~5350 MHz and 5470~5725 MHz bands. DFS is not required in the 5150~5250 MHz or 5725~5825 MHz bands.
- b) Before initiating a network on a Channel, the Master Device will perform a Channel Availability Check for a specified time duration (Channel Availability Check Time) to ensure that there is no radar system operating on the Channel, using DFS described under subsection a) above.
- c) The Master Device initiates a U-NII network by transmitting control signals that will enable other U-NII devices to Associate with the Master Device.
- d) During normal operation, the Master Device will monitor the Channel (In-Service Monitoring) to ensure that there is no radar system operating on the Channel, using DFS described under a).
- e) If the Master Device has detected a Radar Waveform during In-Service Monitoring as described under d), the Operating Channel of the U-NII network is no longer an Available Channel. The Master Device will instruct all associated Client Device(s) to stop transmitting on this Channel within the Channel Move Time. The transmissions during the Channel Move Time will be limited to the Channel Closing Transmission Time.
- f) Once the Master Device has detected a Radar Waveform it will not utilize the Channel for the duration of the Non-Occupancy Period.
- g) If the Master Device delegates the In-Service Monitoring to a Client Device, then the combination will be tested to the requirements described under d) through f) above.
- h)

### **Client Devices**

- a) A Client Device will not transmit before having received appropriate control signals from a Master Device.
- b) A Client Device will stop all its transmissions whenever instructed by a Master Device to which it is associated and will meet the Channel Move Time and Channel Closing Transmission Time requirements. The Client Device will not resume any transmissions until it has again received control signals from a Master Device.
- c) If a Client Device is performing In-Service Monitoring and detects a Radar Waveform above the DFS Detection Threshold, it will inform the Master Device. This is equivalent to the Master Device detecting the Radar Waveform and d) through f) of section 5.1.1 apply.
- d) Irrespective of Client Device or Master Device detection the Channel Move Time and Channel Closing Transmission Time requirements remain the same.
- e) The client test frequency must be monitored to ensure no transmission of any type has occurred for 30 minutes. Note: If the client moves with the master, the device is considered compliant if nothing appears in the client non-occupancy period test. For devices that shut down (rather than moving channels), no beacons should appear.





Paramenter	Value
Non-occupancy period	Minimum 30 minutes
Channel Availability Check Time	60 seconds
Channel Move Time	10 seconds See Note 1.
Channel Closing Transmission Time	200 milliseconds + an aggregate of 60 milliseconds over remaining 10 second period. See Notes 1 and 2.
U-NII Detection Bandwidth	Minimum 100% of the U-NII 99% transmission power bandwidth. See Note 3.
Note 4. Channel Mayo Time and the Channel Class	a Transmission Time should be performed with Deder Type 0. The

Note 1: Channel Move Time and the Channel Closing Transmission Time should be performed with Radar Type 0. The measurement timing begins at the end of the Radar Type 0 burst.

Note 2: The Channel Closing Transmission Time is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required facilitating a Channel move (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signals will not count quiet periods in between transmissions.

Note 3: During the U-NII Detection Bandwidth detection test, radar type 0 should be used. For each frequency step the minimum percentage of detection is 90 percent. Measurements are performed with no data traffic.



## 5.2 DFS Detection Thresholds

### Table 3: DFS Detection Thresholds for Master Devices and Client Devices With Radar Detection

Maximum Transmit Power	Value (See Notes 1, 2, and 3)		
EIRP ≥ 200 milliwatt	-64 dBm		
EIRP < 200 milliwatt and power spectral density < 10 dBm/MHz	-62 dBm		
EIRP < 200 milliwatt that do not meet the power spectral density requirement	-64 dBm		

Note 1: This is the level at the input of the receiver assuming a 0 dBi receive antenna.

Note 2: Throughout these test procedures an additional 1 dB has been added to the amplitude of the test transmission waveforms to account for variations in measurement equipment. This will ensure that the test signal is at or above the detection threshold level to trigger a DFS response.

Note3: EIRP is based on the highest antenna gain. For MIMO devices refer to KDB Publication 662911 D01.



## 5.3 Radar Test Waveforms

This section provides the parameters for required test waveforms, minimum percentage of successful detections, and the minimum number of trials that must be used for determining DFS conformance. Step intervals of 0.1 microsecond for Pulse Width, 1 microsecond for PRI, 1 MHz for chirp width and 1 for the number of pulses will be utilized for the random determination of specific test waveforms.

Radar Type	Pulse Width (µsec)	PRI (µsec)	Number of Pulses	Minimum Percentage of Successful Detection	Minimum Number of Trials
0	1	1428	18	See Note 1	See Note 1
- 6		Test A: 15 unique PRI values randomly selected from the list of 23 PRI values in Table 5a	$\operatorname{Roundup} \left\{ \begin{pmatrix} \frac{1}{360} \end{pmatrix}, \\ \begin{pmatrix} \frac{19 \cdot 10^6}{\operatorname{PRI}_{\mu \operatorname{sec}}} \end{pmatrix} \right\}$	- 2	
1	1	Test B: 15 unique PRI values randomly selected within the range of 518-3066 µsec, with a minimum increment of 1 µsec, excluding PRI values selected in Test A		60%	30
2	1-5	150-230	23-29	60%	30
3	6-10	200-500	16-18	60%	30
4	11-20	200-500	12-16	60%	30
	Agg	regate (Radar Types 1-4)		80%	120

Note 1: Short Pulse Radar Type 0 should be used for the detection bandwidth test, channel move time, and channel closing time tests.

A minimum of 30 unique waveforms are required for each of the Short Pulse Radar Types 2 through 4. If more than 30 waveforms are used for Short Pulse Radar Types 2 through 4, then each additional waveform must also be unique and not repeated from the previous waveforms. If more than 30 waveforms are used for Short Pulse Radar Type 1, then each additional waveform is generated with Test B and must also be unique and not repeated from the previous waveforms in Tests A or B.

For example if in Short Pulse Radar Type 1 Test B a PRI of 3066 µsec is selected, the number of pulses would be Round up

$$\left\{ \left(\frac{1}{360}\right) \cdot \left(\frac{19 \cdot 10^6}{3066}\right) \right\} = \text{Round up } \{17.2\} = 18.$$

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Pulse Repetition Frequency Number	Pulse Repetition Frequency (Pulses Per Second)	Pulse Repetition Interval (Microseconds)
1	1930.5	518
2	1858.7	538
3	1792.1	558
4	1730.1	578
5	1672.2	598
6	1618.1	618
7	1567.4	638
8	1519.8	658
9	1474.9	678
10	1432.7	698
11	1392.8	718
12	1355	738
13	1319.3	758
14	1285.3	778
15	1253.1	798
16	1222.5	818
17	1193.3	838
18	1165.6	858
19	1139	878
20	1113.6	898
21	1089.3	918
22	1066.1	938
23	326.2	3066

#### Table 5a - Pulse Repetition Intervals Values for Test A

#### Table 6 – Long Pulse Radar Test Waveform

Radar Type	Pulse Width (µsec)	Chirp Width (MHz)	PRI (µsec)	Number of Pulses per Burst	Number of Bursts	Minimum Percentage of Successful Detection	Minimum Number of Trials
5	50-100	5-20	1000-2000	1-3	8-20	80%	30

The parameters for this waveforms are randomly chosen. Thirty unique waveforms are required for the Long Pulse Radar Type waveforms. If more than 30 waveforms are used for the Long Pulse Radar Type waveforms, then each additional waveform must also be unique and not repeated from the previous waveforms.



Radar Type	Pulse Width (µsec)	PRI (µsec)	Pulses per Hop	Hopping Rate (kHz)	Hopping Sequence Length (msec)	Minimum Percentage of Successful Detection	Minimum Number of Trials
6	1	333	9	0.333	300	70%	30

#### Table 7 – Frequency Hopping Radar Test Waveform

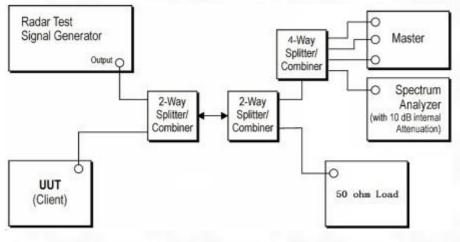
For the Frequency Hopping Radar Type, the same Burst parameters are used for each wave form. The hopping sequence is different for each wave form and a 100-length segment is selected from the hopping sequence defined by the following algorithm:

The first frequency in a hopping sequence is selected randomly from the group of 475 integer frequencies from 5250–5724MHz.Next,the frequency that was just chosen is removed from the group and a frequency is randomly selected from the remaining 474 frequencies in the group. This process continues until all 475 frequencies are chosen for the set. For selection of a random frequency, the frequencies remaining within the group are always treated as equally likely.



# 6. Test Item6.1 Calibration of Radar Waveform

### 6.1.1 TEST CONFIGURATION



### 6.1.2 Test Procedure

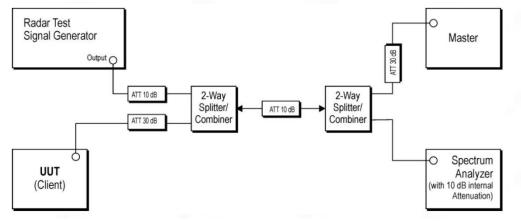
- a) A 50 ohm load is connected in place of the spectrum analyzer, and the spectrum analyzer is connected to place of the master
- b) The interference Radar Detection Threshold Level is -62dBm + 0dBi +1dB = -61dBm that had been taken into account the output power range and antenna gain.
- c) The following equipment setup was used to calibrate the conducted radar waveform. A vector signal generator was utilized to establish the test signal level for radar type 0. During this process there were no transmissions by either the master or client device. The spectrum analyzer was switched to the zero spans (time domain) at the frequency of the radar waveform generator. Peak detection was used. The spectrum analyzer resolution bandwidth (RBW) and video bandwidth (VBW) were set to 3MHz. The spectrum analyzer had offset -1.0dB to compensate RF cable loss 1.0dB.
- d) The vector signal generator amplitude was set so that the power level measured at the spectrum analyzer was
  -62dBm + 0dBi +1dB = -61dBm. Capture the spectrum analyzer plots on short pulse radar waveform.
- 6.1.3 Test Result

Please refer to ANNEX A.1



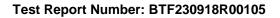
## 6.2 Channel Move Time, Channel Closing Transmission Time

### 6.2.1 TEST CONFIGURATION



### 6.2.2 Test Procedure

- a) The radar pulse generator is setup to provide a pulse at frequency that the master and client are operating. A type 0 radar pulse with a 1us pulse width and a 1428us PRI is used for the testing.
- b) The vector signal generator is adjusted to provide the radar burst (18 pulses) at the level of approximately 61dBm at the antenna port of the master device.
- c) A trigger is provided from the pulse generator to the DFS monitoring system in order to capture the traffic and the occurrence of the radar pulse.
- d) EUT will associate with the master at channel. The file "iperf.exe" specified by the FCC is streamed from the PC 2 through the master and the client device to the PC 1 and played in full motion video using Media Player Classic Ver. 6.4.8.6 in order to properly load the network for the entire period of the test.
- e) When radar burst with a level equal to the DFS Detection Threshold +1dB is generated on the operating channel of the U-NII device. At time T0 the radar waveform generator sends a burst of pulse of the radar waveform at Detection Threshold +1dB.
- f) Observe the transmissions of the EUT at the end of the radar Burst on the Operating Channel Measure and record the transmissions from the UUT during the observation time (Channel Move Time). One 15 seconds plot is reported for the Short Pulse Radar Type 0. The plot for the Short Pulse Radar Types start at the end of the radar burst. The Channel Move Time will be calculated based on the zoom in 600ms plot of the Short Pulse Radar Type
- g) Measurement of the aggregate duration of the Channel Closed Transmission Time method. With the spectrum analyzer set to zero span tuned to the center frequency of the EUT operating channel at the radar simulated





frequency, peak detection, and max hold, the dwell time per bin is given by: Dwell (0.3ms) =S (12000ms) / B (4000); where Dwell is the dwell time per spectrum analyzer sampling bin, S is sweep time and B is the number of spectrum analyzer sampling bins. An upper bound of the aggregate duration of the intermittent control signals of Channel Closing Transmission Time is calculated by: C (ms)= N X Dwell (0.3ms); where C is the Closing Time, N is the number of spectrum analyzer sampling bins (intermittent control signals) showing a U-NII transmission and Dwell is the dwell time per bin.

- h) Measurement the EUT for more than 30 minutes following the channel move time to verify that no transmission or beacons occur on this channel.
- 6.2.3 Test Result

Please refer to ANNEX A



## **ANNEX A Test Results**

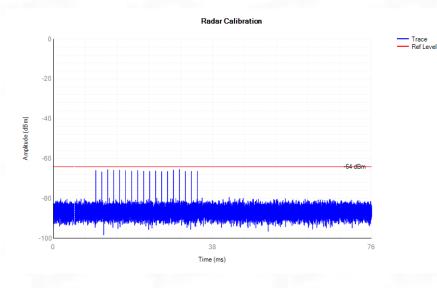
Test Items	Remark	Result
Channel Closing Transmission Time	Applicable	PASS
Channel Move Time	Applicable	PASS

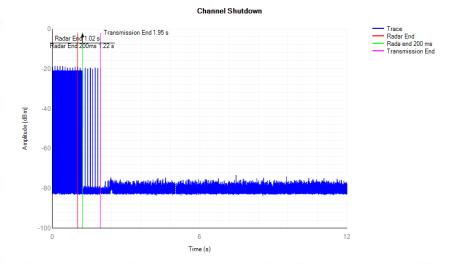
Note: This phone can only be used as a slave without radar detection function, and no signal was recovered in 30 minutes for Non-Occupancy period.

Measurement Record (the wost case)

Measurement data below:

5320MHz					
Test Items	Value (s)	Limit (s)	Test Result		
Channel Closing Transmission Time	0.044	0.26	Pass		
Channel Move Time	0.9217	10	Pass		

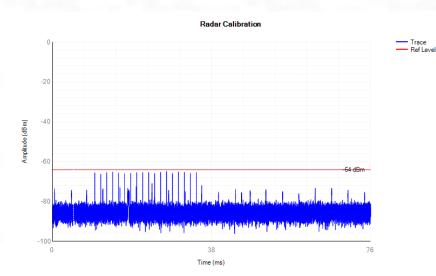


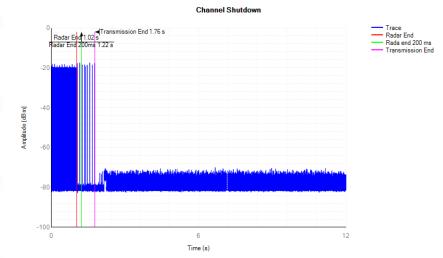




#### Measurement data below:

5500MHz				
Test Items	Value (s)	Limit (s)	Test Result	
Channel Closing Transmission Time	0.0096	0.26	Pass	
Channel Move Time	0.7393	10	Pass	







Test Report Number: BTF230918R00105



BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

www.btf-lab.com

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